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Fairchild Semiconductor FCPF400N60

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FAIRCHILD

SEMICONDUCTOR[®]

FCPF400N60 N-Channel SuperFET[®] II MOSFET 600 V, 10 A, 400 mΩ

Features

- 650 V @ T_J = 150°C
- Typ. R_{DS(on)} = 350 mΩ
- Ultra Low Gate Charge (Typ. Q_g = 28 nC)
- Low Effective Output Capacitance (Typ. C_{oss(eff.)} = 90 pF)
- 100% Avalanche Tested
- RoHS Compliant

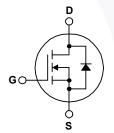
Applications

- LCD / LED / PDP TV Lighting
- Solar Inverter
- AC-DC Power Supply

Description

SuperFET[®] II MOSFET is Fairchild Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SuperFET II MOSFET is very suitable for the switching power applications such as PFC, server/telecom power, FPD TV power, ATX power and industrial power applications.





Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol		Parameter		FCPF400N60	Unit
V _{DSS}	Drain to Source Voltage			600	V
V _{GSS}	Gate to Source Voltage	- DC	- DC		V
		- AC	(f > 1 Hz)	±30	- V
ID	Drain Current	- Continuous (T _C = 25 ^o C)		10*	A
		- Continuous (T _C = 100 ^o C)		6.3*	
I _{DM}	Drain Current	- Pulsed	(Note 1)	30*	А
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		211.6	mJ	
I _{AR}	Avalanche Current (Note 1)		2.3	А	
E _{AR}	Repetitive Avalanche Energy (Note 1)		1.06	mJ	
dv/dt	MOSFET dv/dt			100	V/ns
	Peak Diode Recovery dv/dt (Note 3)		20		
P _D	Power Dissinction	$(T_{C} = 25^{\circ}C)$		31	W
	Power Dissipation	- Derate Above 25°C		0.25	W/ºC
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C	
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		300	°C	
Drain current lim	ited by maximum junction temperatu	ıre.	ľ		

Thermal Characteristics

Symbol	Parameter	FCPF400N60	Unit
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case, Max.	4.0	°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient, Max.	62.5	°C/W

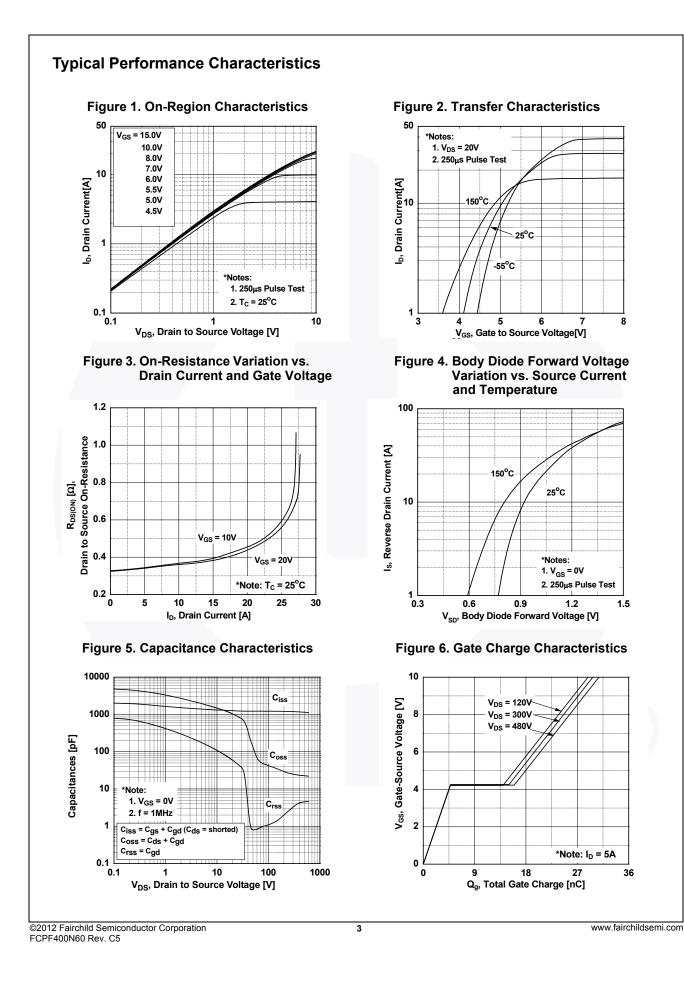
December 2014



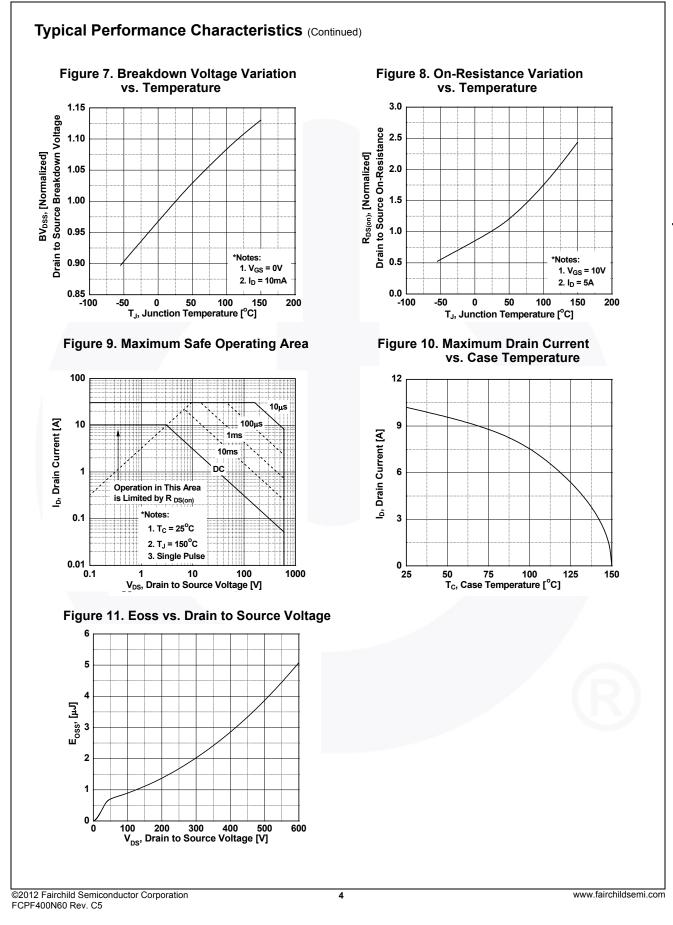
DN60 FCPF400N60 Characteristics T _C = 25 Parameter	TO-220F							
<u> </u>		Tube	N/A		N/A	50	Quantity 50 units	
<u> </u>	^o C unless c	otherwise noted.						
Falameter		Test Conditions		Min.	Тур.	Max.	Unit	
eristics								
		V _{GS} = 0 V, I _D = 10 mA, T _J = 2	25°C	600	-	-	v	
		$V_{GS} = 0 V, I_D = 10 mA, T_J = 150^{\circ}C$		650	-	-	v	
. .	2	$I_D = 10 \text{ mA}, \text{ Referenced to } 25^{\circ}\text{C}$		-	0.67	-	V/ºC	
	own	V _{GS} = 0 V, I _D = 10 A		-	700	-	V	
Zero Gate Voltage Drain Current		V_{DS} = 600 V, V_{GS} = 0 V		-	-	1	μA	
-		20 0		-	0.97	-	· ·	
Gate to Body Leakage Current		$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$		-	-	±100	nA	
eristics								
Gate Threshold Voltage		V_{GS} = V_{DS} , I_D = 250 μ A		2.5	-	3.5	V	
Static Drain to Source On Resista	ance	V _{GS} = 10 V, I _D = 5 A		-	0.35	0.40	Ω	
Forward Transconductance		V _{DS} = 20 V, I _D = 5 A		-	11	-	S	
naracteristics								
				-	1180	1580	pF	
Output Capacitance				-	860	1144	pF	
Reverse Transfer Capacitance				-	43	54	pF	
Output Capacitance				-	22	-	pF	
Effective Output Capacitance		V_{DS} = 0 V to 480 V, V_{GS} = 0	V	-	90	-	pF	
		V _{DS} = 380 V, I _D = 5 A,		-	28	38	nC	
		V _{GS} = 10 V	(Note 4)			-	nC	
		6 - 4 MU-	(Note 4)	-		-	nC	
Equivalent Series Resistance				-	1	-	Ω	
Characteristics								
Turn-On Delay Time				-	13	37	ns	
Turn-On Rise Time				-	7	24	ns	
		$V_{\rm GS} = 10 \text{V}, \text{R}_{\rm G} = 4.7 \Omega$		-			ns	
Turn-Off Fall Time			(Note 4)	-	6	21	ns	
ce Diode Characteristics								
Maximum Continuous Drain to Sc	ource Diode	Forward Current		-	-	10	Α	
Maximum Pulsed Drain to Source	Diode For	ward Current		-	-	30	Α	
Drain to Source Diode Forward V	oltage	V _{GS} = 0 V, I _{SD} = 5 A		-	-	1.2	V	
Reverse Recovery Time		V _{GS} = 0 V, I _{SD} = 5 A,		-	240	-	ns	
Reverse Recovery Charge		dI _F /dt = 100 A/µs		-	2.7	-	μC	
	Breakdown Voltage Temperature Coefficient Drain-Source Avalanche Breakdo Voltage Zero Gate Voltage Drain Current Gate to Body Leakage Current eristics Gate Threshold Voltage Static Drain to Source On Resist: Forward Transconductance naracteristics Input Capacitance Output Capacitance Output Capacitance Effective Output Capacitance Output Capacitance Effective Output Capacitance Total Gate Charge at 10V Gate to Source Gate Charge Gate to Drain "Miller" Charge Equivalent Series Resistance Characteristics Turn-On Delay Time Turn-Off Delay Time Turn-Off Fall Time Ce Diode Characteristics Maximum Continuous Drain to Source Drain to Source Diode Forward V	Drain-Source Avalanche Breakdown Voltage Zero Gate Voltage Drain Current Gate to Body Leakage Current eristics Gate Threshold Voltage Static Drain to Source On Resistance Forward Transconductance naracteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Output Capacitance Effective Output Capacitance Total Gate Charge at 10V Gate to Source Gate Charge Gate to Drain "Miller" Charge Equivalent Series Resistance Characteristics Turn-On Delay Time Turn-Off Delay Time Turn-Off Fall Time Ce Diode Characteristics Maximum Continuous Drain to Source Diode Maximum Pulsed Drain to Source Diode Forward Voltage	$\begin{tabular}{ c c c c c } \hline U_{GS} = 0 \ V, \ I_D = 10 \ mA, \ T_J = 0 \ $	$\begin{tabular}{ c c c c c } \hline U_{GS} = 0 & V, & I_D = 10 & mA, & T_J = 150^\circ C \\ \hline V_{GS} = 0 & V, & I_D = 10 & mA, & T_J = 150^\circ C \\ \hline V_{GS} = 10 & mA, & Referenced to 25^\circ C \\ \hline Drain-Source Avalanche Breakdown \\ Voltage \\ \hline Drain-Source Avalanche Breakdown \\ Voltage \\ \hline V_{GS} = 0 & V, & I_D = 10 & A \\ \hline V_{DS} = 600 & V, & V_{GS} = 0 & V \\ \hline V_{DS} = 480 & V, & T_C = 125^\circ C \\ \hline Gate to Body Leakage Current \\ \hline V_{GS} = 480 & V, & T_C = 125^\circ C \\ \hline Gate to Body Leakage Current \\ \hline V_{GS} = 10 & V, & I_D = 50 & M \\ \hline eristics \\ \hline Gate Threshold Voltage \\ \hline V_{GS} = 10 & V, & I_D = 5 & A \\ \hline Forward Transconductance \\ \hline V_{DS} = 20 & V, & I_D = 5 & A \\ \hline haracteristics \\ \hline Input Capacitance \\ Output Capacitance \\ Output Capacitance \\ Output Capacitance \\ Output Capacitance \\ \hline V_{DS} = 20 & V, & V_{GS} = 0 & V, \\ f = 1 & MHz \\ \hline MHz \\ \hline Hut Capacitance \\ \hline V_{DS} = 380 & V, & V_{GS} = 0 & V, \\ f = 1 & MHz \\ \hline Output Capacitance \\ \hline V_{DS} = 0 & V to 480 & V, & V_{GS} = 0 & V \\ \hline Total Gate Charge at 10V \\ \hline V_{DS} = 380 & V, & I_D = 5 & A, \\ \hline Gate to Drain "Miller" Charge \\ \hline Equivalent Series Resistance \\ \hline Turn-On Dielay Time \\ Turn-On Rise Time \\ Turn-Off Delay Time \\ Turn-Off Delay Time \\ Turn-Off Fall Time \\ \hline Turn-Off Fall Time \\ \hline$	$\begin{array}{ c c c c c } \label{eq:constraint} \begin{tabular}{ c c c c } \hline U_{GS} = 0 \ V, \ I_{D} = 10 \ mA, \ T_{u} = 150^{\circ} C & 650 \\ \hline V_{GS} = 0 \ V, \ I_{D} = 10 \ mA, \ Referenced to 25^{\circ} C & - \\ \hline Drain-Source Avalanche Breakdown \\ \hline V_{GS} = 0 \ V, \ I_{D} = 10 \ A & - \\ \hline V_{DS} = 480 \ V, \ T_{C} = 125^{\circ} C & - \\ \hline V_{DS} = 480 \ V, \ T_{C} = 125^{\circ} C & - \\ \hline Call to Body Leakage Current & V_{GS} = 20 \ V, \ V_{DS} = 0 \ V & - \\ \hline V_{DS} = 480 \ V, \ T_{C} = 125^{\circ} C & - \\ \hline eristics & & & \\ \hline eristics & & & \\ \hline Cate Threshold Voltage & V_{GS} = V_{DS}, \ I_{D} = 250 \ \mu A & 2.5 \\ \hline Static Drain to Source On Resistance & V_{DS} = 20 \ V, \ I_{D} = 5 \ A & - \\ \hline Forward Transconductance & V_{DS} = 20 \ V, \ I_{D} = 5 \ A & - \\ \hline Paracteristics & & & \\ \hline Input Capacitance & V_{DS} = 250 \ V, \ V_{GS} = 0 \ V, \ f = 1 \ MHz & - \\ \hline Output Capacitance & V_{DS} = 380 \ V, \ V_{GS} = 0 \ V, \ f = 1 \ MHz & - \\ \hline Output Capacitance & V_{DS} = 380 \ V, \ V_{GS} = 0 \ V & - \\ \hline Total Gate Charge at 10V & V_{DS} = 380 \ V, \ V_{GS} = 0 \ V & - \\ \hline Gate to Drain "Miller" \ Charge & V_{CS} = 10 \ V & - \\ \hline Cate to Drain "Miller" \ Charge & f = 1 \ MHz & - \\ \hline Characteristics & & \\ \hline Turn-On Rise Time & V_{DS} = 380 \ V, \ I_{D} = 5 \ A, & - \\ \hline Turn-Off Delay Time & & - \\ \hline Turn-Off Delay Time & & \\ \hline Turn-Off Fall Time & (Note 4) \ - \\ \hline Ce Diode \ Characteristics & \\ \hline Maximum Continuous Drain to Source Diode Forward Current & - \\ \hline Maximum Pulsed Drain to Source Diode Forward Current & - \\ \hline Drain to Source Diode Forward Voltage & V_{GS} = 0 \ V, \ I_{SD} = 5 \ A & - \\ \hline \end{array}$	$\begin{tabular}{ c c c c c } \hline U_{GS} = 0 \ V, \ I_D = 10 \ mA, \ T_J = 150^\circ C & 650 & - \\ \hline V_{GS} = 0 \ V, \ I_D = 10 \ mA, \ Referenced to 25^\circ C & - & 0.67 \\ \hline Drain-Source Avalanche Breakdown Voltage & V_{GS} = 0 \ V, \ I_D = 10 \ A & - & 700 \\ \hline V_{DS} = 480 \ V, \ T_C = 125^\circ C & - & 0.97 \\ \hline Q_{SC} = 0 \ V, \ U_{DS} = 0 \ V & - & - & - \\ \hline V_{DS} = 480 \ V, \ T_C = 125^\circ C & - & 0.97 \\ \hline Gate to Body Leakage Current & V_{GS} = 20 \ V, \ V_{DS} = 0 \ V & - & - & - \\ \hline eristics & & & & & & & & & & & & & & & & & & &$	$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	

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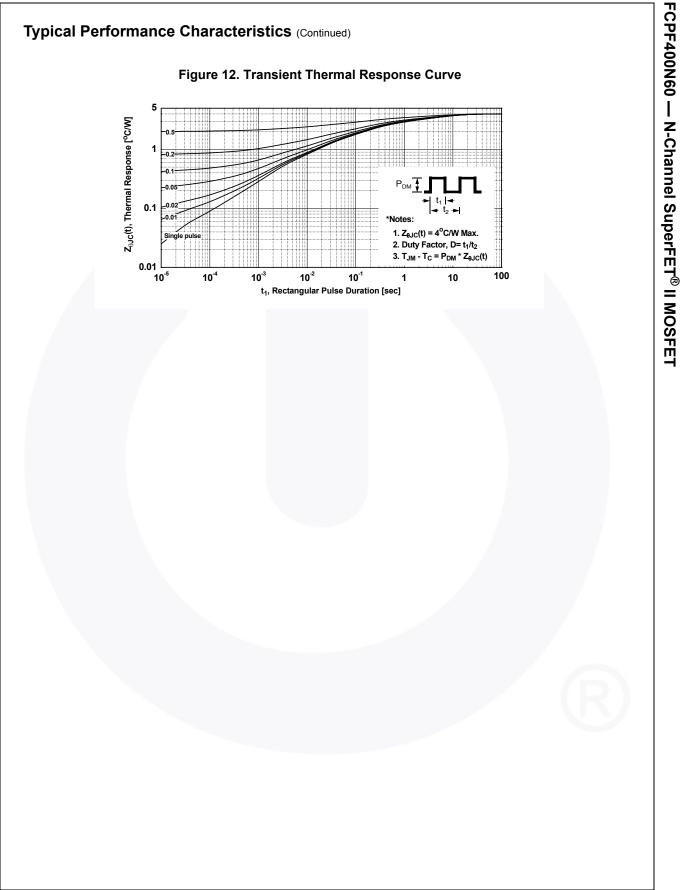






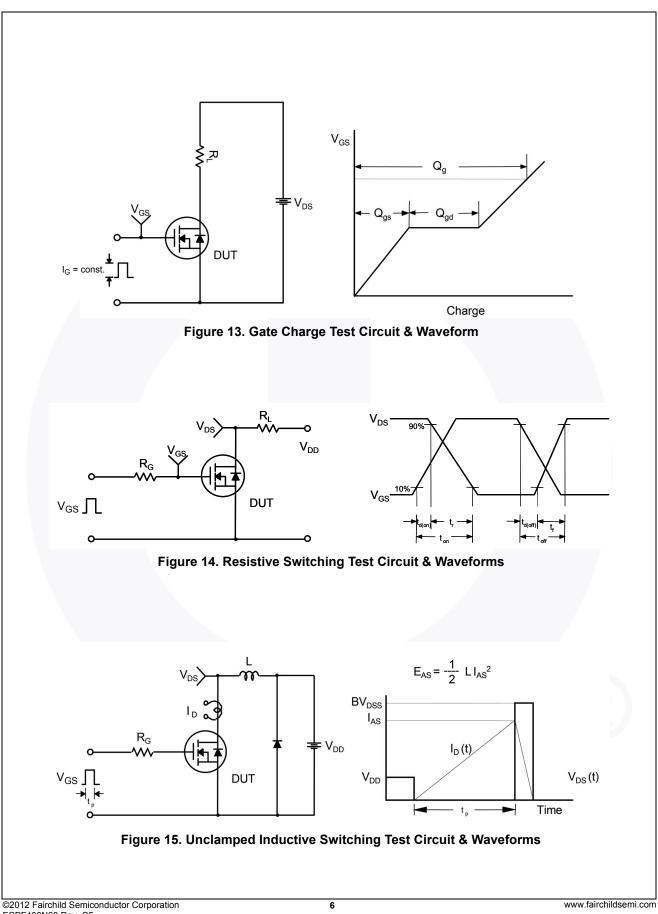






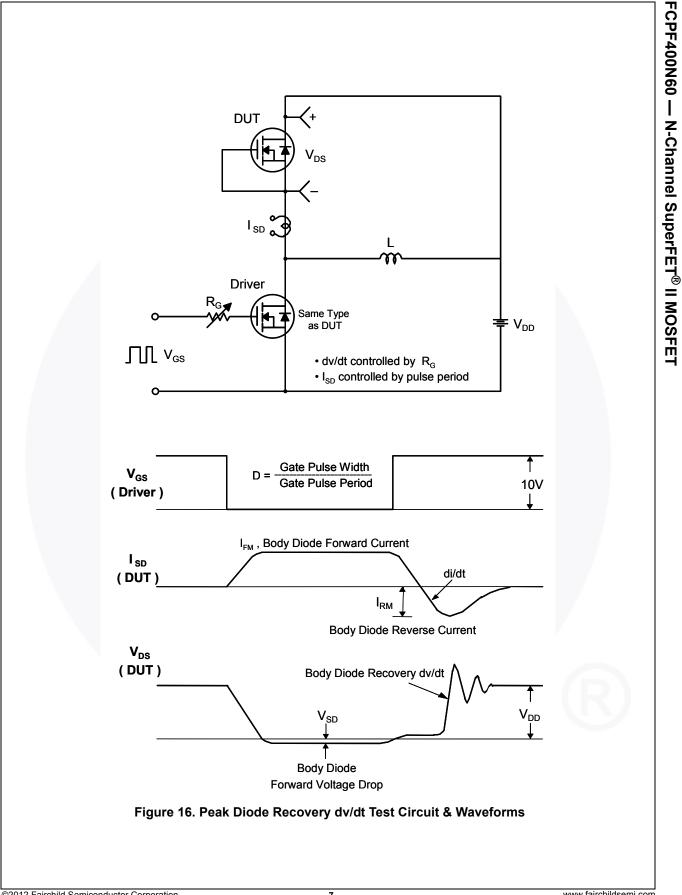


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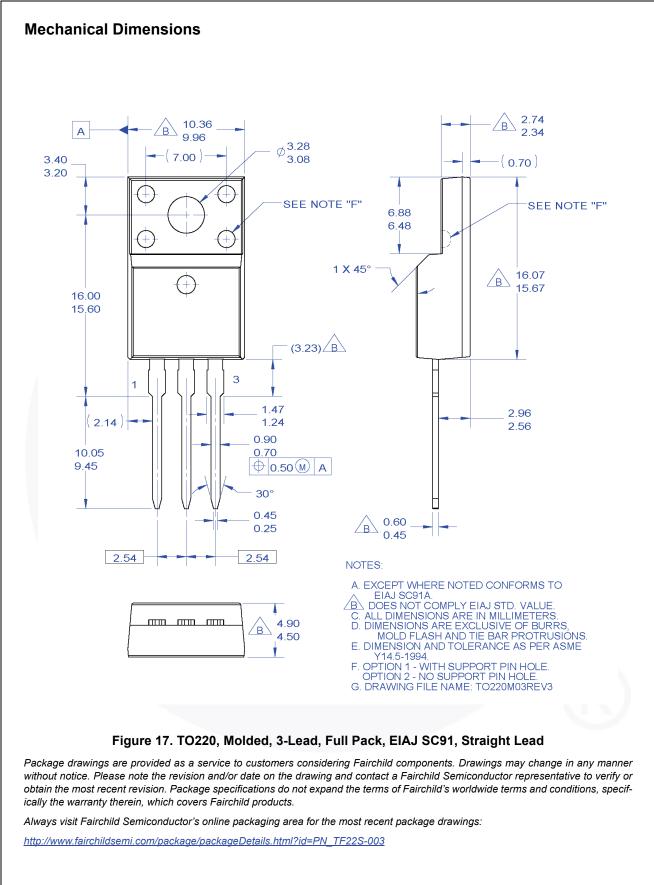


FCPF400N60 Rev. C5









FCPF400N60 — N-Channel SuperFET[®] II MOSFET





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